

Search Notes

Application/Control No.

10/604,172

Examiner

Cheukfan Lee

Applicant(s)/Patent under
Reexamination

HSU ET AL.

Art Unit

2625

SEARCHED

Class	Subclass	Date	Examiner
358	497	1/31/2008	C.L.
	494		
	474		
382	312		
	318,319		
399	211		
	379		
	380		
250	234-236		
	239		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search: see result, mainly image search	1/31/2008	C.L.
Inventor search		
References only: Han (5,907,413), 66 < 64, Takahashi et al. (5,689,348), front, Yoshida et al. (5,113,268), front		